

Notice of References Cited

Application/Control No.

09/859,684

Applicant(s)/Patent Under
Reexamination
HAHN ET AL.

Examiner

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Art Unit

2614

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-5,329,311	07-1994	Ward et al.	348/180
X	B	US-5,418,574	05-1995	Miyabata et al.	348/625
X	C	US-5,387,946	02-1995	Knee, Michael	348/622
X	D	US-5,425,114	06-1995	Hamasaki et al.	382/254
X	E	US-5,969,777	10-1999	Mawatari, Masahiko	375/240.26
X	F	US-6,169,583	01-2001	Merkel et al.	348/607
X	G	US-6,370,279	04-2002	Paik, Joon-ki	382/268
X	H	US-6,377,299	04-2002	Hamada, Takahiro	348/192
X	I	US-6,496,605	12-2002	Osa, Kinya	382/268
X	J	US-6,529,637	03-2003	Cooper, Carl	382/267
X	K	US-6,600,839	07-2003	Mancuso et al.	382/268
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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